

### IPD100N04S4-02-VB Datasheet

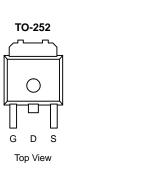
N-Channel 40-V (D-S) MOSFET

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PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, c</sup>	Q <sub>g</sub> (Typ.)		
40	0.0016 at V <sub>GS</sub> = 10 V	120	120 nC		
40	0.0020 at V <sub>GS</sub> = 4.5 V	100	120110		
			D		





100 % R<sub>g</sub> and UIS Tested

#### APPLICATIONS

- Synchronous Rectification
- Power Supplies

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	40			
Gate-Source Voltage		V <sub>GS</sub>	± 25	V	
	T <sub>C</sub> = 25 °C		120 <sup>a, c</sup>	A	
Continuous Drain Current (T 175 °C)	T <sub>C</sub> = 70 °C		96 <sup>c</sup>		
Continuous Drain Current ( $T_J = 175 \ ^{\circ}C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	29 <sup>b</sup>		
	T <sub>A</sub> = 70 °C		23 <sup>b</sup>		
Pulsed Drain Current	I <sub>DM</sub>	250	-		
Avalanche Current Pulse			96		
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	320	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	L.	120 <sup>a, c</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	2.6 <sup>b</sup>	— A	
	T <sub>C</sub> = 25 °C		312 <sup>a</sup>		
Mariana Dissission	T <sub>C</sub> = 70 °C		200		
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.13 <sup>b</sup>		
	T <sub>A</sub> = 70 °C		2.0 <sup>b</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b</sup>	Steady State	R <sub>thJA</sub>	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.33	0.4	0,00	

Notes:

a. Based on  $T_C = 25 \ ^{\circ}C$ .

b. Surface Mounted on 1" x 1" FR4 board.

c. Calculated based on maximum junction temperature. Package limitation current is 120 A.

B	<sup>®</sup> VBsemi
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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	40			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		41		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	iD = 200 μΛ		- 8		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.2		2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
	I <sub>DSS</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		1		
Zero Gate Voltage Drain Current		$V_{DS}$ = 40 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			10 µA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5$ V, $V_{GS}$ = 10 V	120			А
	Р	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 30 \text{ A}$		0.0016		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS}$ = 4.5 V, I <sub>D</sub> = 20 A		0.0020		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A		180		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			9000		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 20 V, V_{GS} = 0 V, f = 1 MHz$		650		
Reverse Transfer Capacitance	C <sub>rss</sub>			450		
Total Gate Charge	Qg			120	180	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 20 V, $V_{GS}$ = 10 V, $I_D$ = 20 A		30		
Gate-Drain Charge	Q <sub>gd</sub>			16		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		0.85	1.3	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			20	30	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 1.0 $\Omega$		11	17	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>	${\rm I}_{\rm D}{\cong}20$ A, ${\rm V}_{\rm GEN}$ = 10 V, ${\rm R}_{\rm g}$ = 1 $\Omega$		77	115	
Fall Time	t <sub>f</sub>			10	15	
Turn-On Delay Time	t <sub>d(on)</sub>			102	155	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 1.0 $\Omega$		62	95	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 20$ A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		180	270	
Fall Time	t <sub>f</sub>			60	90	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			110	А
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				200	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 20 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			50	75	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 20.4 di/dt = 100.4/m T = 25.90		70	105	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		30		
Reverse Recovery Rise Time	t <sub>b</sub>	-1		20		ns

Notes:

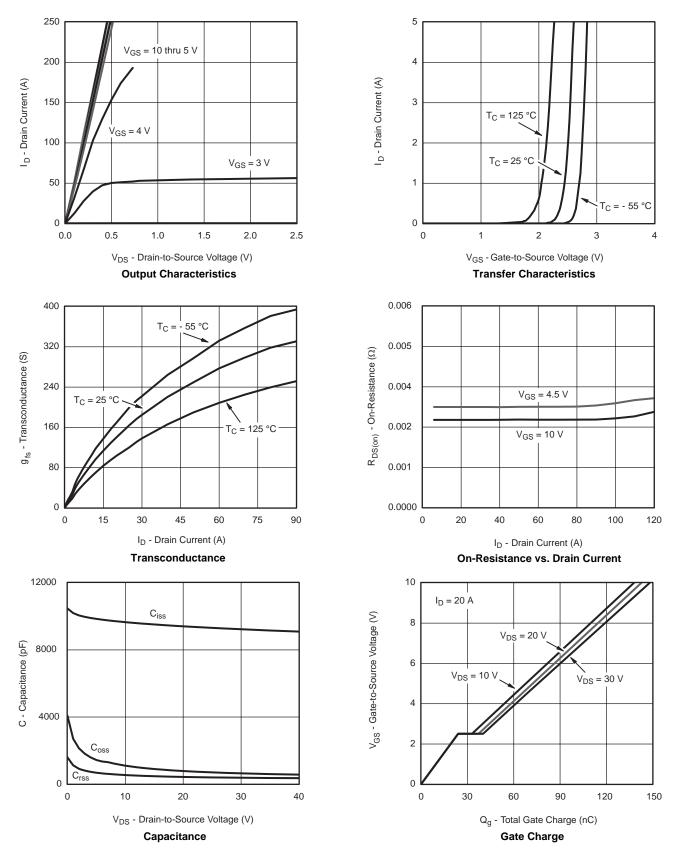
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

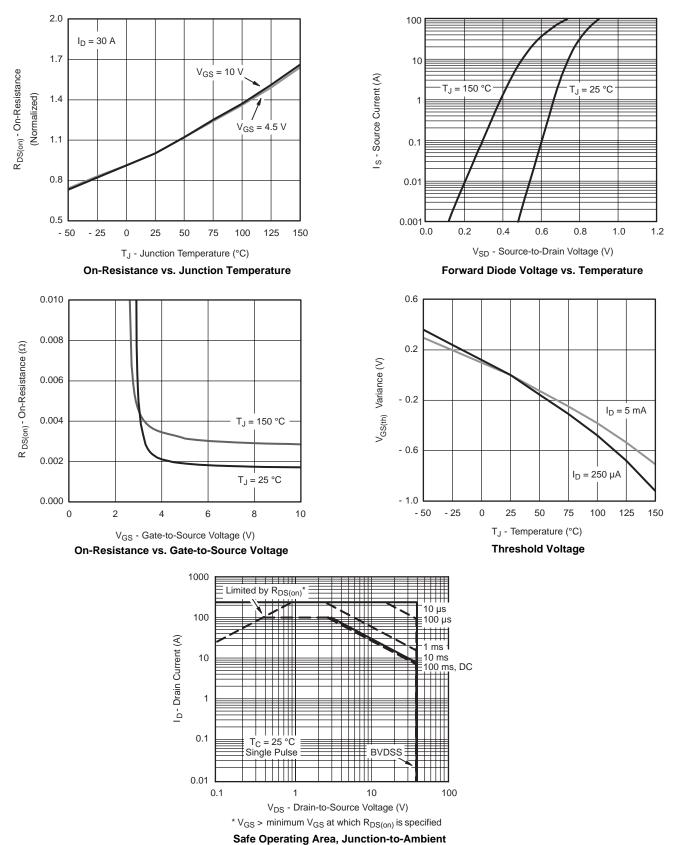


#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

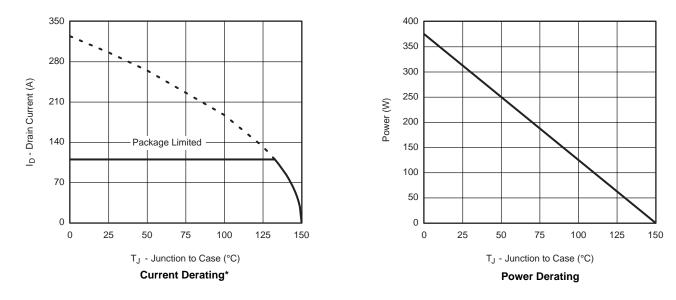




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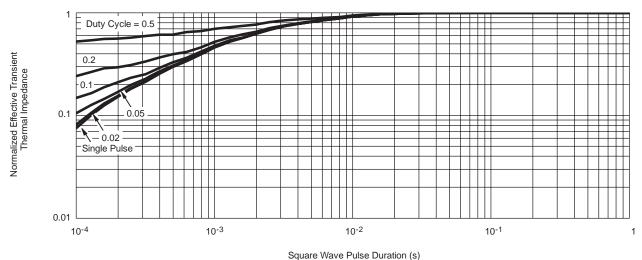






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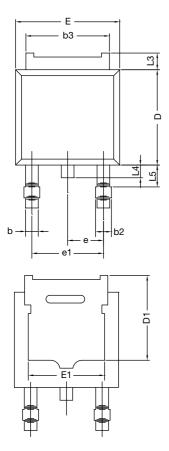
\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

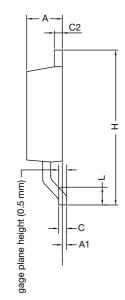


Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-252AA CASE OUTLINE**





	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



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